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- EPIC ™ (Enhanced-Performance Implanted CMOS) Submicron Process
- Typical V<sub>OLP</sub> (Output Ground Bounce)
  < 0.8 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C
- Typical V<sub>OHV</sub> (Output V<sub>OH</sub> Undershoot)
  2 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C
- Latch-Up Performance Exceeds 250 mA
  Per JEDEC Standard JESD-17
- Package Options Include Plastic Small-Outline (DW), Shrink Small-Outline (DB), and Thin Shrink Small-Outline (PW) Packages

## DB, DW, OR PW PACKAGE (TOP VIEW)

	_			
OE1	1	U	20	] v <sub>cc</sub>
A1	2		19	OE2
A2	3		18	] Y1
A3	4		17	] Y2
A4	5		16	] Y3
A5	6		15	] Y4
A6	7		14	] Y5
A7	8		13	] Y6
A8	9		12	] Y7
GND	10		11	] Y8
				ı

#### description

This octal buffer/driver is designed for 2.7-V to 3.6-V V<sub>CC</sub> operation.

The SN74LVC541 is ideal for driving bus lines or buffering memory address registers. The device features inputs and outputs on opposite sides of the package to facilitate printed-circuit-board layout.

The 3-state control gate is a 2-input AND gate with active-low inputs so that if either output enable (OE1 or OE2) input is high, all eight outputs are in the high-impedance state.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN74LVC541 is characterized for operation from -40°C to 85°C.

#### **FUNCTION TABLE**

INPUTS			OUTPUT
OE1	OE2	Α	Υ
L	L	L	L
L	L	Н	Н
Н	X	X	Z
X	Н	Χ	Z

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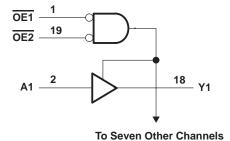


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#### logic symbol†

#### 1 OE1 ΕN 19 OE2 2 18 $\nabla$ Y1 **A1** 3 17 Α2 **Y2** 4 16 **A3 Y3** 5 15 **Y4** Α4 6 14 Α5 Y5 13 **A6 Y6** 8 12 Α7 **Y7** 9 11 Δ8 **Y8**

#### logic diagram (positive logic)



#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V <sub>CC</sub> –0.5 V to 4.6 V
Input voltage range, V <sub>I</sub> (see Note 1)
Output voltage range, $V_O$ (see Notes 1 and 2)
Input clamp current, $I_{IK}$ ( $V_I < 0$ )
Output clamp current, $I_{OK}$ ( $V_O < 0$ or $V_O > V_{CC}$ )
Continuous output current, $I_O$ ( $V_O = 0$ to $V_{CC}$ ) $\pm 50$ mA
Continuous current through V <sub>CC</sub> or GND ±100 mA
Maximum power dissipation at T <sub>A</sub> = 55°C (in still air) (see Note 3): DB package
DW package 1.6 W
PW package 0.7 W
Storage temperature range, T <sub>stq</sub> –65°C to 150°C

<sup>‡</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
  - 2. This value is limited to 4.6 V maximum.
  - 3. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils. For more information, refer to the *Package Thermal Considerations* application note in the 1994 *ABT Advanced BiCMOS Technology Data Book*, literature number SCBD002B.



<sup>&</sup>lt;sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

#### recommended operating conditions (see Note 4)

			MIN	MAX	UNIT
Vсс	Supply voltage		2.7	3.6	V
VIH	High-level input voltage	V <sub>CC</sub> = 2.7 V to 3.6 V	2		V
VIL	Low-level input voltage	$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$		0.8	V
٧ı	Input voltage		0	5.5	V
٧o	Output voltage		0	VCC	V
1	High-level output current	V <sub>CC</sub> = 2.7 V		-12	
ЮН		V <sub>CC</sub> = 3 V		-24	mA
lOL	Low-level output current	V <sub>CC</sub> = 2.7 V		12	mA
	VCC = 3 V			24	IIIA
Δt/ΔV	Input transition rise or fall rate		0	10	ns/V
TA	Operating free-air temperature		-40	85	°C

NOTE 4: Unused inputs must be held high or low to prevent them from floating.

#### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	v <sub>cc</sub> †	MIN TYP‡	MAX	UNIT	
	$I_{OH} = -100 \mu\text{A}$	MIN to MAX	V <sub>CC</sub> -0.2			
Va.,	10.1. — 12.mA	2.7	2.2		v	
VOH	I <sub>OH</sub> = – 12 mA	3	2.4		v	
	$I_{OH} = -24 \text{ mA}$	3	2		]	
	$I_{OL} = 100 \mu\text{A}$	MIN to MAX		0.2	\ \	
VOL	$I_{OL} = 12 \text{ mA}$	2.7		0.4		
	I <sub>OL</sub> = 24 mA	3		0.55		
lį	V <sub>I</sub> = 5.5 V or GND	3.6		±5	μΑ	
loz	$V_O = V_{CC}$ or GND	3.6		±10	μΑ	
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	3.6		20	μΑ	
ΔlCC	One input at V <sub>CC</sub> – 0.6 V, Other inputs at V <sub>CC</sub> or GND	3 V to 3.6 V		500	μΑ	
Ci	$V_I = V_{CC}$ or GND	3.3	5.5		pF	
Co	$V_O = V_{CC}$ or GND	3.3	5.8		pF	

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate values under recommended operating conditions. ‡ All typical values are at  $V_{CC} = 3.3 \text{ V}$ ,  $T_A = 25 ^{\circ}\text{C}$ .

# switching characteristics over recommended operating free-air temperature range, $C_L$ = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 3.3 V ± 0.3 V		V <sub>CC</sub> = 2.7 V		UNIT
	(INPOT)		MIN	MAX	MIN	MAX	
t <sub>pd</sub>	A	Y	1.5	7		8	ns
t <sub>en</sub>	ŌĒ	Y	1.5	8		9	ns
<sup>t</sup> dis	ŌĒ	Y	1.5	7.5		8.5	ns

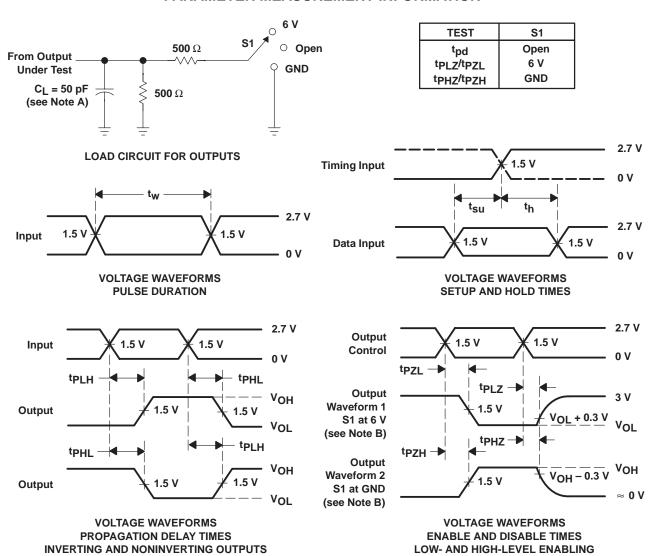


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### operating characteristics, $V_{CC}$ = 3.3 V, $T_A$ = 25°C

PARAMETER		TEST COI	TYP	UNIT	
C <sub>pd</sub>	Power dissipation capacitance per buffer/driver	Outputs enabled	C <sub>L</sub> = 50 pF, f = 10 MHz	26.7	nE.
		Outputs disabled		I = IU MIHZ	1.8

#### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_Q = 50~\Omega$ ,  $t_f \leq 2.5~ns$ ,  $t_f \leq 2.5~ns$ .
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpZL and tpZH are the same as ten.
- G. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



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